

FORM PTO 1449 (modified)				APPLY DOCKET NO. 03500.017977.	APPLICATION NO. 10/809,483		
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANT	MASAYA ASAOKA, et al.		
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				FILING DATE March 26, 2004	GROUP 1751		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		B. D. Cullity, "Elements of X-RAY DIFFRACTION", 2 nd Ed., Addison-Wesley Publishing Company, Inc., pp. 100-103.					
		Diffraction: Real Samples, http://www-lam.stanford.edu/xlab/MatSci162_172/LectureNotes/04_Real%20Samples.pdf , pp. 1-55, visited October 22, 2007.					
		5-Lecture notes for Clay Mineralogy, http://www.gly.uga.edu/schroeder/geol6550/CM05.html , pp. 1-8, visited October 22, 2007.					
EXAMINER				DATE CONSIDERED			

***EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.**

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